PowerPhase, Dual N-Channel SO8FL

30 V, High Side 20 A / Low Side 24 A

Features

- Co-Packaged Power Stage Solution to Minimize Board Space
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC-DC Converters
- System Voltage Rails
- Point of Load

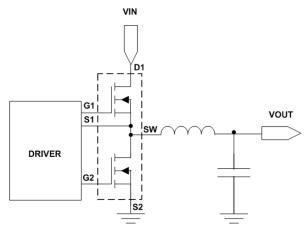


Figure 1. Typical Application Circuit

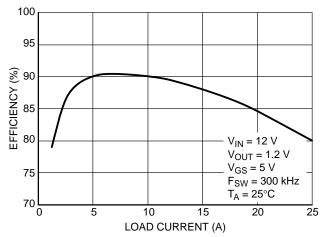


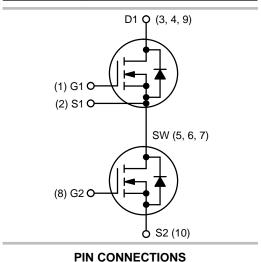
Figure 2. Typical Efficiency Performance **POWERPHASEGEVB Evaluation Board**



ON Semiconductor®

www.onsemi.com

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| Q1 Top FET | 5.4 mΩ @ 10 V | 20.4 |
| 30 V | 8.1 mΩ @ 4.5 V | 20 A |
| Q2 Bottom | 4.4 mΩ @ 10 V | 24 A |
| FET 30 V | 6.0 mΩ @ 4.5 V | 24 A |



5 SW 10 6 SW S2 D' 7 SW 8 G2 G1 (Bottom View)



DIAGRAM



MARKING

4C88N = Specific Device Code = Assembly Location Υ = Year

W = Work Week = Lot Traceability

ORDERING INFORMATION

See detailed ordering and shipping information on page 10 of this data sheet.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

| Parameter | | Symbol | Value | Unit | | |
|--|--------|---|-------|-------------------|-------------|-----|
| Drain-to-Source Voltage | Q1 | V _{DSS} | 30 | V | | |
| Drain-to-Source Voltage | Q2 | | | | | |
| Gate-to-Source Voltage | Q1 | V _{GS} | ±20 | V | | |
| Gate-to-Source Voltage | | | Q2 | | | |
| Continuous Drain Current R _{0JA} (Note 1) | | T _A = 25°C | Q1 | I _D | 15.4 | |
| | | T _A = 85°C | | | 11.1 | 1 , |
| | | T _A = 25°C | Q2 | | 18.7 | A |
| | | T _A = 85°C | | | 13.5 | |
| Power Dissipation | | T _A = 25°C | Q1 | P _D | 1.89 | W |
| RθJA (Note 1) | | | Q2 | | | |
| Continuous Drain Current $R_{\theta JA} \le 10 \text{ s (Note 1)}$ | | T _A = 25°C | Q1 | I _D | 21.0 | |
| | | T _A = 85°C | | | 15.1 | A |
| | Steady | $T_A = 25^{\circ}C$ | Q2 | | 25.4 | |
| | State | $T_A = 85^{\circ}C$ | | | 18.3 | |
| Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$ | | $T_A = 25^{\circ}C$ | Q1 | P_{D} | 3.51 | W |
| N _{BJA} ≥ 10 3 (Note 1) | | | Q2 | | | |
| Continuous Drain Current $R_{\theta JA}$ (Note 2) | | $T_A = 25^{\circ}C$ | Q1 | I_{D} | 11.7 | |
| N _{HJA} (Note 2) | | $T_A = 85^{\circ}C$ | | | 8.5 | A |
| | | T _A = 25°C | Q2 | | 14.2 | |
| | | $T_A = 85^{\circ}C$ | | | 10.3 | |
| Power Dissipation R _{0.JA} (Note 2) | | T _A = 25 °C | Q1 | P_{D} | 1.10 | W |
| N _{HJA} (Note 2) | | | Q2 | | | |
| Pulsed Drain Current | | $T_A = 25^{\circ}C$ $t_p = 10 \mu s$ | Q1 | I _{DM} | 160 | Α |
| | | τρ = 10 μ3 | Q2 | | 240 | |
| Operating Junction and Storage Temperature | | | Q1 | T_J , T_{STG} | -55 to +150 | °C |
| | Q2 | | | | | |
| Source Current (Body Diode) | Q1 | IS | 10 | Α | | |
| | Q2 | | 10 | | | |
| Drain to Source DV/DT | • | dV/dt | 6 | V/ns | | |
| Single Pulse Drain–to–Source Avalanche Energy (T V_{DD} = 50 V, V_{GS} = 10 V, L = 0.1 mH, R_{G} = 25 Ω) | Q1 | EAS | 20 | mJ | | |
| — 00 v, v _{GS} = 10 v, L = 0.1 mm, n _G = 20 s ₂) | Q2 | EAS | 29 | | | |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | TL | 260 | °C | | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted on FR4 board using 1 sq—in pad, 2 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size of 100 mm².

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|--|-----------------|-------|------|
| Junction-to-Ambient - Steady State (Note 3) | $R_{\theta JA}$ | 66.0 | |
| Junction-to-Ambient - Steady State (Note 4) | $R_{\theta JA}$ | 113.7 | °C/W |
| Junction–to–Ambient – (t \leq 10 s) (Note 3) | $R_{\theta JA}$ | 35.6 | |

- 3. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
- 4. Surface–mounted on FR4 board using the minimum recommended pad size of 100 mm².

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | FET | Symbol | mbol Test Condition | | Min | Тур | Max | Unit |
|--|------|---|--|-------------------------|-----|------|-----|------|
| OFF CHARACTERISTICS | | | | | • | • | • | |
| Drain-to-Source Break- | Q1 | M | $V_{GS} = 0 \text{ V, } I_{D} = 250 \mu\text{A}$ | | 30 | | | V |
| down Voltage | Q2 | V _{(BR)DSS} | $V_{GS} = 0 V$, | I _D = 250 μA | 30 | | | |
| Drain-to-Source Break- down Voltage Temperature | Q1 | V _{(BR)DSS} | | | | 18 | | mV / |
| Coefficient | Q2 | V _{(BR)DSS} /T _J | | | | 17 | | °C |
| | Q1 | | $V_{GS} = 0 V,$ | T _J = 25°C | | | 1 | |
| Zero Gate Voltage Drain | | I _{DSS} | $V_{DS} = 24 \text{ V}$ | T _J = 125°C | | | 10 | μΑ |
| Current | Q2 | .033 | $V_{GS} = 0 V$, $V_{DS} = 24 V$ | T _J = 25°C | | | 1 | |
| Gate-to-Source Leakage | Q1 | | V _{GS} : | = 0 V, | | | 100 | |
| Current | | I _{GSS} | $V_{DS} = \pm 20 \text{ V}$ | | | | 100 | nA |
| ON CHARACTERISTICS (Not | e 5) | | | | | | | |
| Gate Threshold Voltage | Q1 | V | $V_{GS} = VDS$, | | 1.3 | | 2.2 | V |
| | Q2 | $V_{GS(TH)}$ $I_D = 250 \mu A$ | | 250 μA | 1.3 | | 2.2 | |
| Negative Threshold Temper- | Q1 | V _{GS(TH)} / | | | | 4.5 | | mV / |
| ature Coefficient | Q2 | T _J ′ | | | | 4.6 | | °C |
| | Q1 | R _{DS(on)} | $V_{GS} = 10 \text{ V}$ | I _D = 10 A | | 4.3 | 5.4 | _ |
| Drain-to-Source On Resist- | | | $V_{GS} = 4.5 \text{ V}$ | I _D = 10 A | | 6.5 | 8.1 | mΩ |
| ance | Q2 | _ | $V_{GS} = 10 \text{ V}$ | I _D = 20 A | | 2.8 | 4.4 | |
| | | | $V_{GS} = 4.5 \text{ V}$ $I_D = 20 \text{ A}$ | | | 4.0 | 6.0 | |
| CAPACITANCES | | | | | | | | |
| Input Capacitance | Q1 | Cinn | C _{ISS} | | | 1252 | | |
| при Сараскансе | Q2 | OISS | | | | 1546 | | |
| Output Capacitance | Q1 | C _{OSS} V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 | | MHz Vpc = 15 V | | 610 | | pF |
| Calpat Capacitario | Q2 | 9055 | VGS = 0 V, I = I IVII IZ, VDS = 13 V | | | 841 | | |
| Reverse Capacitance | Q1 | C _{RSS} | | | | 126 | | |
| 1.010100 Oapaoltanoo | Q2 | OKSS. | | | | 39 | | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | FET | Symbol | Test Condition | | Min | Тур | Max | Unit |
|-------------------------|--------------|---------------------|---|---|-----|------|-----|------|
| CHARGES, CAPACITANCE | & GATE | RESISTANC | E | | | | • | |
| T. 10 1 01 | Q1 | | | | | 10.9 | | |
| Total Gate Charge | Q2 | $Q_{G(TOT)}$ | | | | 11 | | 1 |
| TI 1 110 1 01 | Q1 | _ | | | | 1.2 | | |
| Threshold Gate Charge | Q2 | Q _{G(TH)} | V 45V/V | 45.77.1 40.4 | | 1.6 | | |
| 0-1-1-0 | Q1 | _ | $V_{GS} = 4.5 \text{ V}, V_{DS}$ | $V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 10 \text{ A}$ | | 3.4 | | nC |
| Gate-to-Source Charge | Q2 | Q_GS | | | | 4.4 | | |
| Onto the Duning Observe | Q1 | 0 | | | | 5.4 | | |
| Gate-to-Drain Charge | Q2 | Q_GD | | | | 2.9 | | |
| T. 10 . 0 | Q1 | | | 45.77.1 40.4 | | 22.2 | | _ |
| Total Gate Charge | Q2 | Q _{G(TOT)} | $V_{GS} = 10 \text{ V}, V_{DS}$ | = 15 V; I _D = 10 A | | 24.2 | | nC |
| 0 | Q1 | R_{G} | _ | | | 1.0 | | |
| Gate Resistance | Q2 | | I _A = | 25°C | | 1.0 | | Ω |
| SWITCHING CHARACTERIS | STICS (No | te 6) | | | | | • | |
| | Q1 | | | | | 9.4 | | |
| Turn-On Delay Time | Q2 | t _{d(ON)} | | | | | | 1 |
| Rise Time - | Q1 | | | | | 19 | | |
| | Q2 | t _r | $V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 15 \text{ A}, R_G = 3.0 \Omega$ | | | 4.8 | | |
| T 0" D T | Q1 | , | $I_D = 15 A$, | $R_G = 3.0 \Omega$ | | 16 | | ns |
| Turn-Off Delay Time | Q2 | t _{d(OFF)} | | | | 19.3 | | |
| E-U.T. | Q1 | | | | | 4.6 | | |
| Fall Time | Q2 | t _f | | | | 4.7 | | |
| SWITCHING CHARACTERIS | STICS (No | te 6) | | | | | | |
| Turn On Dolov Time | Q1 | | | | | 6.8 | | |
| Turn-On Delay Time | Q2 | t _{d(ON)} | | | | 7.5 | | |
| Diag Time | Q1 | | | | | 17 | | |
| Rise Time | Q2 | t _r | V _{GS} = 10 V, | $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ | | 2.7 | | ns |
| Town Off Dalay Trees | Q1 | | $I_D = 15 \text{ A}, R_G = 3.0 \Omega$ | | | 20.6 | | |
| Turn-Off Delay Time | Q2 | ^t d(OFF) | | | | 24.8 | | |
| | Q1 | | | | | 2.64 | | |
| Fall Time | Fall Time Q2 | | | | | 2.88 | | |
| DRAIN-SOURCE DIODE CH | IARACTE | RISTICS | | | | | | |
| | | | $V_{GS} = 0 \text{ V},$ | $T_J = 25^{\circ}C$ | | 0.82 | | |
| Famous and Malks | Q1 | ., | $V_{GS} = 0 V,$ $I_{S} = 10 A$ | T _J = 125°C | | 0.64 | |] ,, |
| Forward Voltage | 6.5 | V_{SD} | V _{GS} = 0 V, | T _J = 25°C | | 0.8 | | _ |
| | Q2 | | $I_{S} = 10 \text{ A}$ | T _J = 125°C | | 0.62 | | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

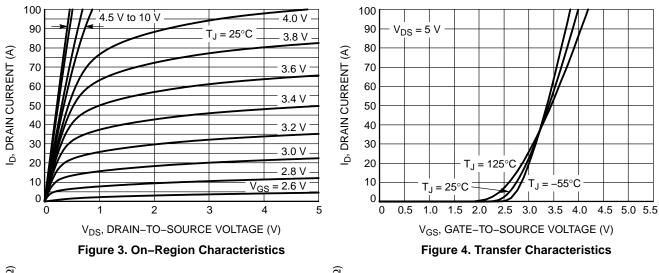
Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | FET | Symbol | Test Condition | Min | Тур | Max | Unit | |
|-------------------------|-------|----------|--|-----|------|------|------|--|
| DRAIN-SOURCE DIODE CHA | RACTE | RISTICS | | | | | | |
| Povorco Pocovory Timo | Q1 | 4 | | | 29 | | | |
| Reverse Recovery Time | Q2 | чRR | t _{RR} | | 16.7 | | | |
| Chargo Timo | Q1 | to | ta | | 14.2 | | ns | |
| Charge Time | Q2 | та | | | 19.5 | | | |
| Discharge Time | Q1 | 4h | $V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s}, I_S = 10 \text{ A}$ | | 15.0 | | | |
| Discharge Time | Q2 | tb | lb | | | 36.2 | | |
| Dayaraa Dagayary Charga | Q1 | | | | 18.1 | | 20 | |
| Reverse Recovery Charge | Q2 | Q_{RR} | | | 27.4 | | nC | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS - Q1



DRAIN-TO-SOURCE RESISTANCE (₺) DRAIN-TO-SOURCE RESISTANCE (₺) 0.026 0.009 0.024 0.022 $I_{D} = 20 \text{ A}$ 0.008 $T_J = 25^{\circ}C$ 0.020 V_{GS} = 4.5 V 0.018 0.007 0.016 0.014 0.006 0.012 0.005 0.010 V_{GS} = 10 V 0.008 0.006 0.004 R_{DS(on)}, I R_{DS(on)}, I 0.004 0.003 0.002 7 20 30 40 50 6 8 9 10 10 60 70 4 5 V_{GS}, GATE VOLTAGE (V) ID, DRAIN CURRENT (A)

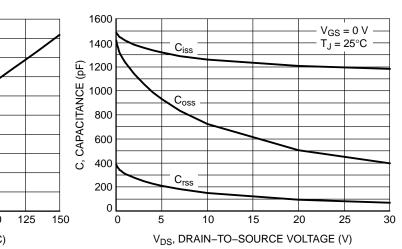
Figure 5. On-Resistance vs. Gate-to-Source Voltage

1.7

V_{GS} = 10 V

 $I_{D} = 20 \text{ A}$

0.7



-25 25 50 75 100 -50 T_J, JUNCTION TEMPERATURE (°C)

Figure 7. On-Resistance Variation with **Temperature**

Figure 8. Capacitance Variation

Figure 6. On-Resistance vs. Drain Current and **Gate Voltage**

TYPICAL CHARACTERISTICS - Q1

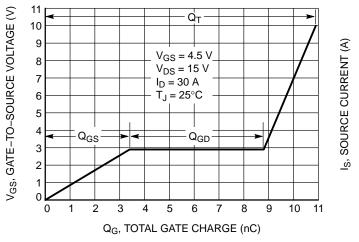


Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

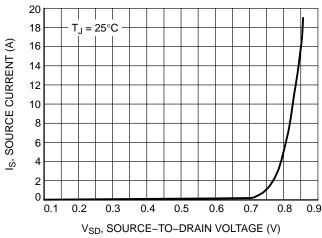


Figure 10. Diode Forward Voltage vs. Current

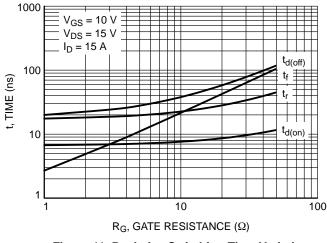


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

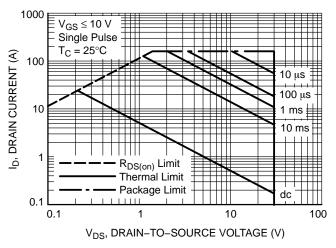


Figure 12. Maximum Rated Forward Biased Safe Operating Area

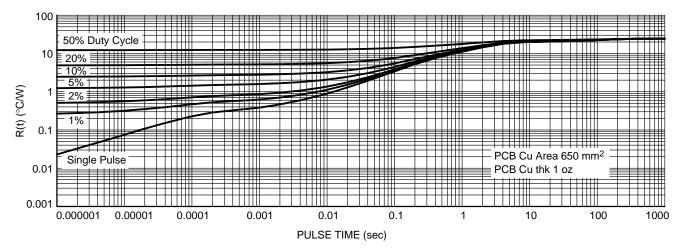


Figure 13. Thermal Characteristics

TYPICAL CHARACTERISTICS - Q2

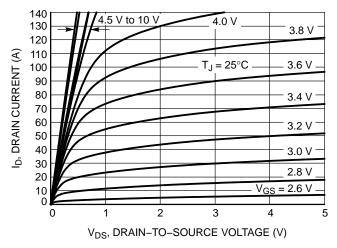


Figure 14. On-Region Characteristics

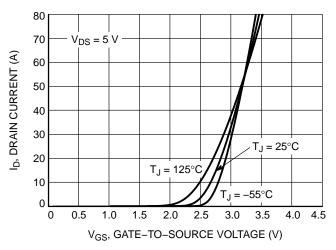


Figure 15. Transfer Characteristics

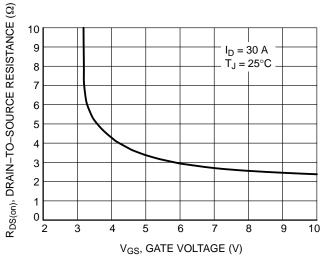


Figure 16. On-Resistance vs. Gate-to-Source Voltage

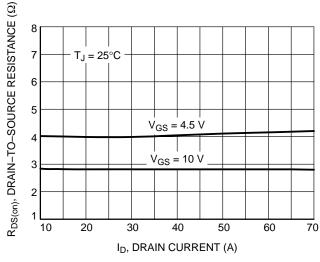


Figure 17. On-Resistance vs. Drain Current and Gate Voltage

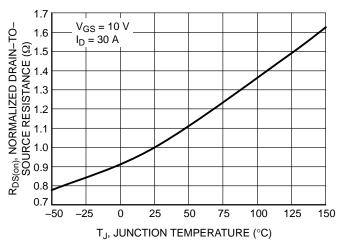


Figure 18. On–Resistance Variation with Temperature

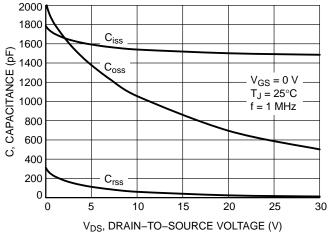


Figure 19. Capacitance Variation

TYPICAL CHARACTERISTICS - Q2

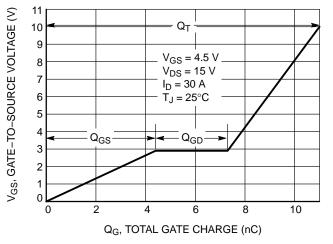


Figure 20. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

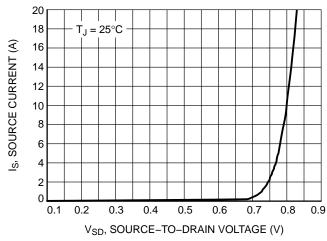


Figure 21. Diode Forward Voltage vs. Current

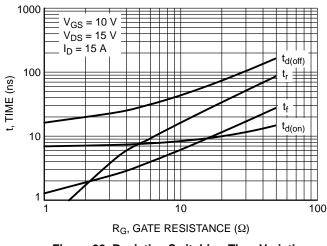


Figure 22. Resistive Switching Time Variation vs. Gate Resistance

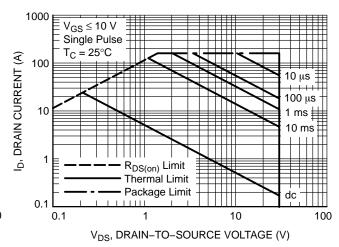


Figure 23. Maximum Rated Forward Biased Safe Operating Area

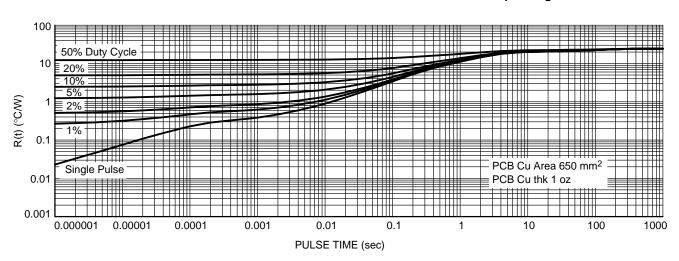


Figure 24. Thermal Characteristics

ORDERING INFORMATION

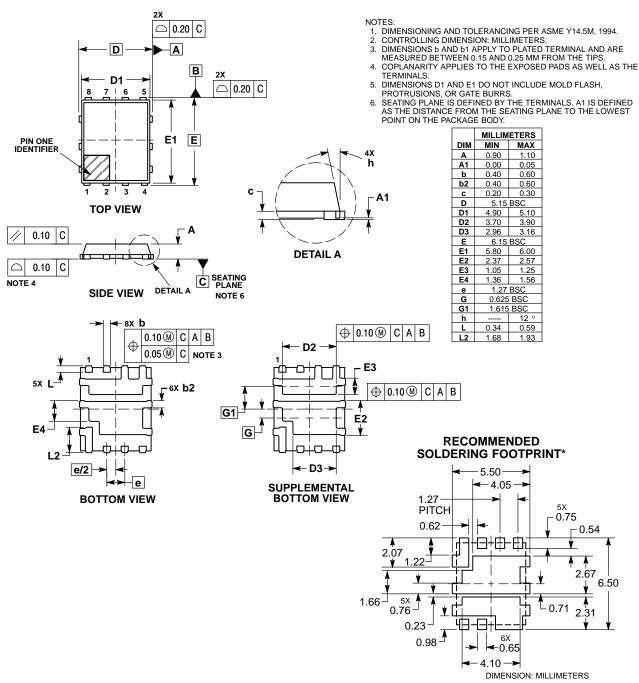
| Device | Package | Shipping [†] |
|---------------|-------------------|-----------------------|
| NTMFD4C88NT1G | DFN8 (Pb-Free) | 1500 / Tape & Reel |
| NTMFD4C88NT3G | DFN8 (Pb-Free) | 5000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DFN8 5x6, 1.27P PowerPhase FET

CASE 506CR ISSUE C



^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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